#### 查询SN54AHCT02供应商

### 捷多邦,专业PCB打样SN54AH@T02出SN74AHCT02 QUADRUPLE 2-INPUT POSITIVE-NOR GATES

SN54AHCT02 ... J OR W PACKAGE

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- EPIC™ (Enhanced-Performance Implanted CMOS) Process
- Inputs Are TTL-Voltage Compatible
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

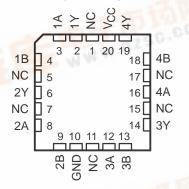
#### description

These devices contain four independent 2-input NOR gates that perform the Boolean function  $Y = \overline{A} \cdot \overline{B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

The SN54AHCT02 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74AHCT02 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

| SN74AHCT02D, DB, DGV, N, OR PW PACKAGE<br>(TOP VIEW) |   |        |  |  |  |  |  |  |  |
|--|---|--------|--|--|--|--|--|--|--|
| 1Y [   | 1 | 14 VCC |  |  |  |  |  |  |  |
| 1A [   | 2 | 13 4Y  |  |  |  |  |  |  |  |
| 1B [   | 3 | 12 4B  |  |  |  |  |  |  |  |
| 2Y [   | 4 | 11 4A  |  |  |  |  |  |  |  |
| 2A [   | 5 | 10 3Y  |  |  |  |  |  |  |  |
| 2B [   | 6 | 9 3B   |  |  |  |  |  |  |  |
| GND [  | 7 | 8 3A   |  |  |  |  |  |  |  |

SN54AHCT02...FK PACKAGE (TOP VIEW)



NC – No internal connection

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|----|
|    |

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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FUNCTION TABLE (each gate)

В

Х

Н

L

OUTPUT Y

L

L

Н

INPUTS

Α

Н

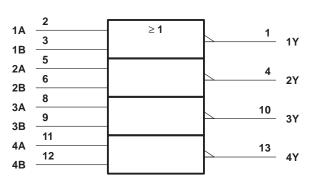
Х

L

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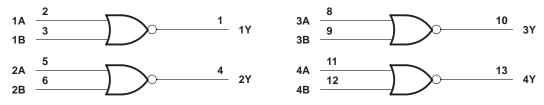
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### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

### logic diagram (positive logic)



Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

| Supply voltage range, V <sub>CC</sub>   |              | –0.5 V to 7 V                          |
|---|--------------|--|
| Input voltage range, V <sub>I</sub> (see Note 1)                                      |              | –0.5 V to 7 V                          |
| Output voltage range, V <sub>O</sub> (see Note 1)                                     |              | –0.5 V to V <sub>CC</sub> + 0.5 V      |
| Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)                             |              |  |
| Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>C</sub> |              |  |
| Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$                         | -            | ±25 mA                                 |
| Continuous current through V <sub>CC</sub> or GND                                     |              | ±50 mA                                 |
| Package thermal impedance, $\theta_{JA}$ (see Note 2)                                 | ): D package |  |
|   | DB package   |  |
|   | DGV package  | 127°C/W                                |
|   | N package    | 80°C/W                                 |
|   | PW package   | 113°C/W                                |
| Storage temperature range, T <sub>stg</sub>   |              | $\dots -65^{\circ}C$ to $150^{\circ}C$ |

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.



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#### recommended operating conditions (see Note 3)

|                     |                                    | SN54A | HCT02 | SN74A | UNIT |      |
|---------------------|------------------------------------|-------|-------|-------|------|------|
|                     |                                    | MIN   | MAX   | MIN   | MAX  | UNIT |
| VCC                 | Supply voltage                     | 4.5   | 5.5   | 4.5   | 5.5  | V    |
| VIH                 | High-level input voltage           | 2     |       | 2     |      | V    |
| VIL                 | Low-level input voltage            |       | 0.8   |       | 0.8  | V    |
| VI                  | Input voltage                      | 0     | 5.5   | 0     | 5.5  | V    |
| Vo                  | Output voltage                     | 0     | VCC   | 0     | VCC  | V    |
| ЮН                  | High-level output current          |       | -8    |       | -8   | mA   |
| IOL                 | Low-level output current           |       | 8     |       | 8    | mA   |
| $\Delta t/\Delta v$ | Input transition rise or fall rate |       | 20    |       | 20   | ns/V |
| Т <sub>А</sub>      | Operating free-air temperature     | -55   | 125   | -40   | 85   | °C   |

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS   | Vaa          | T <sub>A</sub> = 25°C |     |      | SN54AHCT02 |      | SN74AHCT02 |      | UNIT |
|-----------|---|--------------|-----------------------|-----|------|------------|------|------------|------|------|
| FARAMETER |   | Vcc          | MIN                   | TYP | MAX  | MIN        | MAX  | MIN        | MAX  | UNIT |
| Vou       | I <sub>OH</sub> = -50 μA                                      | 4.5 V        | 4.4                   | 4.5 |      | 4.4        |      | 4.4        |      | V    |
| Voh       | I <sub>OH</sub> = -8 mA                                       | 4.5 V        | 3.94                  |     |      | 3.8        |      | 3.8        |      | v    |
| Ve        | I <sub>OL</sub> = 50 μA                                       | 4.5 V        |                       |     | 0.1  |            | 0.1  |            | 0.1  | v    |
| VOL       | I <sub>OL</sub> = 8 mA  |              |                       |     | 0.36 |            | 0.44 |            | 0.44 |      |
| li        | $V_I = V_{CC}$ or GND   | 0 V to 5.5 V |                       |     | ±0.1 |            | ±1*  |            | ±1   | μA   |
| ICC       | $V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$            | 5.5 V        |                       |     | 2    |            | 20   |            | 20   | μA   |
| ∆ICC‡     | One input at 3.4 V,<br>Other inputs at GND or V <sub>CC</sub> | 5.5 V        |                       |     | 1.35 |            | 1.5  |            | 1.5  | mA   |
| Ci        | $V_{I} = V_{CC} \text{ or } GND$                              | 5 V          |                       | 4   | 10   |            |      |            | 10   | pF   |

\* On products compliant to MIL-PRF-38535, this parameter is not production tested at  $V_{CC} = 0 V$ .

<sup>†</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER        | FROM TO |                          | LOAD                    | LOAD $T_A = 25^{\circ}C$ |       | SN54AHCT02 |     | SN74AHCT02 |     |     |      |
|------------------|---------|--------------------------|-------------------------|--------------------------|-------|------------|-----|------------|-----|-----|------|
|                  | (INPUT) | NPUT) (OUTPUT)           | CAPACITANCE             | MIN                      | TYP   | MAX        | MIN | MAX        | MIN | MAX | UNIT |
| <sup>t</sup> PLH | A or B  | Y                        | C <sub>L</sub> = 15 pF  |                          | 2.4** | 5.5**      | 1** | 6.5**      | 1   | 6.5 | ns   |
| <sup>t</sup> PHL | AUD     |                          |                         |                          | 3.5** | 5.5**      | 1** | 6.5**      | 1   | 6.5 | 115  |
| <sup>t</sup> PLH | A or B  | Y C <sub>L</sub> = 50 pF | $C_{1} = 50 \text{ pF}$ |                          | 3.4   | 7.5        | 1   | 8.5        | 1   | 8.5 |      |
| <sup>t</sup> PHL | AUD     |                          | Y CL = 50 pF            |                          | 4.5   | 7.5        | 1   | 8.5        | 1   | 8.5 | ns   |

\*\* On products compliant to MIL-PRF-38535, this parameter is not production tested.



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## noise characteristics, V\_{CC} = 5 V, C\_L = 50 pF, T\_A = 25^{\circ}C (see Note 4)

|                    | PARAMETER                                     |   |     |      | UNIT |
|--------------------|---|---|-----|------|------|
|                    | PARAMETER                                     |   | TYP | MAX  | UNIT |
| VOL(P)             | Quiet output, maximum dynamic V <sub>OL</sub> |   |     | 0.8  | V    |
| V <sub>OL(V)</sub> | Quiet output, minimum dynamic V <sub>OL</sub> |   |     | -0.8 | V    |
| VOH(V)             | Quiet output, minimum dynamic V <sub>OH</sub> |   | 4.7 |      | V    |
| VIH(D)             | High-level dynamic input voltage              | 2 |     |      | V    |
| VIL(D)             | Low-level dynamic input voltage               |   |     | 0.8  | V    |

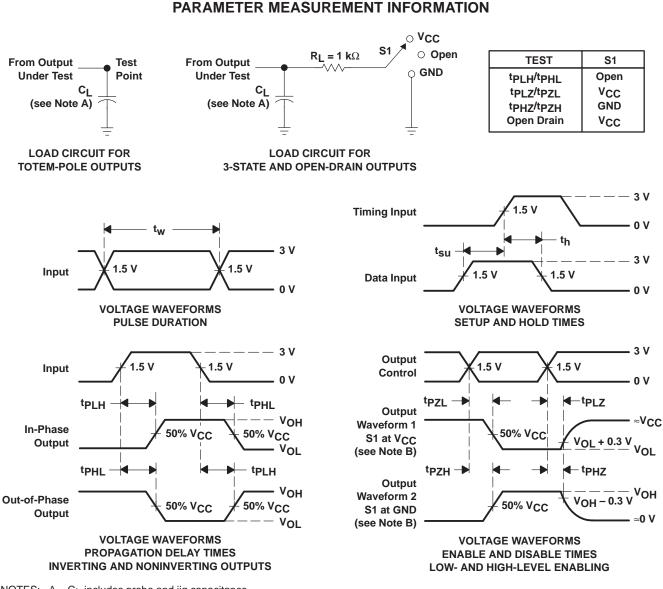
NOTE 4: Characteristics are for surface-mount packages only.

## operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

|     | PARAMETER TEST COND           |          | ONDITIONS | TYP | UNIT |
|-----|-------------------------------|----------|-----------|-----|------|
| Cpd | Power dissipation capacitance | No load, | f = 1 MHz | 17  | pF   |



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NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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